

Amendments to the Claims:

This listing of claims will replace all prior versions and listings of claims in the application.

Listing of Claims:

1. (Currently amended) An information recording medium comprising a substrate and a recording material layer formed on the substrate, the recording material layer undergoing reversible phase change between electrically or optically detectable states by electric energy or by electromagnetic energy, wherein

the recording material layer comprises a material selected from a material 'A' having a crystal structure comprising a lattice defect in one phase of the reversible phase change; or a material 'B' in a complex phase composed of a crystal portion comprising a lattice defect and an amorphous portion in one phase of the reversible phase change, and the crystal portion and the amorphous portion comprise a common element; and

at least a part of the lattice defect is filled with an element other than an element constituting the crystal structure[.].

the crystal structure comprising the lattice defect comprises Ge, Sb and Te,

the crystal structure comprising the lattice defect further comprises at least one element selected from Sn, Cr, Mn, Ag, Al, Pb, In and Se, and

the crystal structure comprising the lattice defect further comprises at least one combination of elements selected from Sn-Cr, Sn-Mn, Sn-Ag, Mn-Ag, Cr-Ag, Sn-Mn, and Sn-Cr-Ag.

2. (Original) The information recording medium according to claim 1, wherein a molar ratio of the amorphous portion to the crystalline portion in the complex phase of the material 'B' is 2.0 at most.

3. (Original) The information recording medium according to claim 1, wherein the reversible phase change of the material 'B' occurs between the complex phase and a single phase.

4. (Original) The information recording medium according to claim 1, wherein the crystal structure comprising the lattice defect is a NaCl type.
5. (Original) The information recording medium according to claim 1, wherein the crystal structure comprising the lattice defect comprises Te or Se.
6. (Original) The information recording medium according to claim 1, wherein the amorphous phase portion composing the complex phase of the material 'B' comprises at least one element selected from Sb, Bi, Ge and In.
7. (Cancelled)
8. (Currently amended) The information recording medium according to claim 1, wherein the crystal structure comprising the lattice defect optionally comprises ~~at least one element selected from Ge, Sb, Bi and Te~~, and the amorphous component in the complex phase comprises at least one element selected from Ge, Sb and Bi.
9. (Cancelled)
10. (Cancelled)
11. (Original) The information recording medium according to claim 1, wherein the element to fill at least a part of the lattice defect forms a stoichiometric rock-salt type crystal that is stable with respect to Te.
12. (Original) The information recording medium according to claim 1, satisfying a relationship represented by  $0.7 R_{nc} < R_{im} \leq 1.05 R_{nc}$ , where  $R_{im}$  denotes an ionic radius of an element filling at least a part of the lattice defect, and  $R_{nc}$  denotes a minimum value of an ionic radius of an element constituting the crystal structure.
13. (Original) The information recording medium according to claim 1, satisfying a

relationship represented by  $|T_{im} - T_{nc}| \leq 100^\circ\text{C}$  where  $T_{im}$  denotes a melting point of an element filling at least a part of the lattice defect, and  $T_{nc}$  denotes a melting point of a crystal constituting the crystal structure.

14. (Original) The information recording medium according to claim 1, satisfying a relationship represented by  $0.7 R_{nc} < R_{im} \leq 1.05 R_{nc}$  and  $|T_{im} - T_{nc}| \leq 100^\circ\text{C}$ , where  $R_{im}$  denotes an ionic radius of an element filling at least one part of the lattice defect,  $T_{im}$  denotes the melting point,  $R_{nc}$  denotes a minimum value of an ionic radius of an element constituting the crystal structure, and  $T_{nc}$  denotes the melting point.

15. (Original) The information recording medium according to claim 1, satisfying a relationship represented by  $D_{im} \leq D_{df} \times 1.5$ , where  $D_{im}$  denotes a concentration of an element added to fill the lattice defect, and  $D_{df}$  denotes a concentration of the lattice defect in the crystal structure.

16. (Original) The information recording medium according to claim 15, wherein the  $D_{im}$  satisfies a relationship represented by  $0.2 \leq D_{im} \leq D_{df}$ .

17. (Original) The information recording medium according to claim 11, wherein the element to fill the lattice defect is at least one element selected from Ag, Sn and Pb.

18. (Currently amended) The information recording medium according to claim 11, wherein the crystal structure comprising the lattice defect is at least a group of elements selected from a  $\text{GeTe-Sb}_2\text{Te}_3$  quasibinary system composition, a  $\text{GeTe-Bi}_2\text{Te}_3$  quasibinary system composition, and a  $\text{GeTe-Al}_2\text{Te}_3$  quasibinary system composition.

19. (Original) The information recording medium according to claim 18, wherein the element to fill the lattice defect is Al.

20. (Currently amended) The information recording medium according to claim 18, wherein the crystal structure comprising the lattice defect comprises  $(\text{GeTe})_{(1-x)}(\text{M}_2\text{Te}_3)_x$  where M denotes

Sb and optionally an element selected from Sb, Bi, Al, and an arbitrary mixture of Sb, Bi, and Al; and x satisfies  $0.2 \leq x \leq 0.9$ .

21. (Original) The information recording medium according to claim 20, wherein x satisfies  $0.5 \leq x \leq 0.9$ .

22. (Original) The information recording medium according to claim 1, further comprising N in the recording film.

23. (Original) The information recording medium according to claim 22, wherein a concentration Dn of the N atom (atom%) is in a range of  $0.5 \leq Dn \leq 5$ .

24-27. (Cancelled)

28. (New) An information recording medium comprising a substrate and a recording material layer formed on the substrate, the recording material layer undergoing reversible phase change between electrically or optically detectable states by electric energy or by electromagnetic energy, wherein

the recording material layer comprises a material selected from a material 'A' having a crystal structure comprising a lattice defect in one phase of the reversible phase change; or a material 'B' in a complex phase composed of a crystal portion comprising a lattice defect and an amorphous portion in one phase of the reversible phase change, and the crystal portion and the amorphous portion comprise a common element; and

at least a part of the lattice defect is filled with an element other than an element constituting the crystal structure,

wherein the element to fill at least a part of the lattice defect forms a stoichiometric rock-salt type crystal that is stable with respect to Te,

the crystal structure comprising the lattice defect is at least a group of elements selected from a GeTe-Sb<sub>2</sub>Te<sub>3</sub> quasibinary system composition, a GeTe-Bi<sub>2</sub>Te<sub>3</sub> quasibinary system composition, and a GeTe-Al<sub>2</sub>Te<sub>3</sub> quasibinary system composition, and

the crystal structure comprising the lattice defect comprises (GeTe)<sub>(1-x)</sub>(M<sub>2</sub>Te<sub>3</sub>)<sub>x</sub> where M

denotes an element selected from Sb, Bi, Al, and an arbitrary mixture of Sb, Bi, and Al; and x satisfies  $0.2 \leq x \leq 0.9$ .

29. (New) The information recording medium according to claim 28, wherein a molar ratio of the amorphous portion to the crystalline portion in the complex phase of the material 'B' is 2.0 at most.

30. (New) The information recording medium according to claim 28, wherein the reversible phase change of the material 'B' occurs between the complex phase and a single phase.

31. (New) The information recording medium according to claim 28, wherein the crystal structure comprising the lattice defect is a NaCl type.

32. (New) The information recording medium according to claim 28, wherein the crystal structure comprising the lattice defect comprises Te or Se.

33. (New) The information recording medium according to claim 28, wherein the amorphous phase portion composing the complex phase of the material 'B' comprises at least one element selected from Sb, Bi, Ge and In.

34. (New) The information recording medium according to claim 28, wherein the crystal structure comprising the lattice defect comprises Ge, Sb and Te.

35. (New) The information recording medium according to claim 28, wherein the crystal structure comprising the lattice defect comprises at least one element selected from Ge, Sb, Bi and Te, and the amorphous component in the complex phase comprises at least one element selected from Ge, Sb and Bi.

36. (New) The information recording medium according to claim 34, wherein the crystal structure comprising the lattice defect further comprises at least one element selected from Sn, Cr, Mn, Ag, Al, Pb, In and Se.

37. (New) The information recording medium according to claim 36, wherein the crystal structure comprising the lattice defect further comprises at least one combination of elements selected from Sn-Cr, Sn-Mn, Sn-Ag, Mn-Ag, Cr-Ag, Sn-Mn, and Sn-Cr-Ag.

38. (New) The information recording medium according to claim 28, satisfying a relationship represented by  $0.7 R_{nc} < R_{im} \leq 1.05 R_{nc}$ , where  $R_{im}$  denotes an ionic radius of an element filling at least a part of the lattice defect, and  $R_{nc}$  denotes a minimum value of an ionic radius of an element constituting the crystal structure.

39. (New) The information recording medium according to claim 28, satisfying a relationship represented by  $|T_{im} - T_{nc}| \leq 100^{\circ}\text{C}$  where  $T_{im}$  denotes a melting point of an element filling at least a part of the lattice defect, and  $T_{nc}$  denotes a melting point of a crystal constituting the crystal structure.

40. (New) The information recording medium according to claim 28, satisfying a relationship represented by  $0.7 R_{nc} < R_{im} \leq 1.05 R_{nc}$  and  $|T_{im} - T_{nc}| \leq 100^{\circ}\text{C}$ , where  $R_{im}$  denotes an ionic radius of an element filling at least one part of the lattice defect,  $T_{im}$  denotes the melting point,  $R_{nc}$  denotes a minimum value of an ionic radius of an element constituting the crystal structure, and  $T_{nc}$  denotes the melting point.

41. (New) The information recording medium according to claim 28, satisfying a relationship represented by  $D_{im} \leq D_{df} \times 1.5$ , where  $D_{im}$  denotes a concentration of an element added to fill the lattice defect, and  $D_{df}$  denotes a concentration of the lattice defect in the crystal structure.

42. (New) The information recording medium according to claim 41, wherein the  $D_{im}$  satisfies a relationship represented by  $0.2 \leq D_{im} \leq D_{df}$ .

43. (New) The information recording medium according to claim 28, wherein the element to fill the lattice defect is at least one element selected from Ag, Sn and Pb.

44. (New) The information recording medium according to claim 28, wherein the element to fill the lattice defect is Al.

45. (New) The information recording medium according to claim 28, wherein x satisfies  $0.5 \leq x \leq 0.9$ .

46. (New) The information recording medium according to claim 28, further comprising N in the recording film.

47. (New) The information recording medium according to claim 46, wherein a concentration Dn of the N atom (atom%) is in a range of  $0.5 \leq Dn \leq 5$ .